

Notice of References Cited

Application/Control No.

10/674,341

Applicant(s)/Patent Under
Reexamination
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Examiner

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Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,933,137	08-1999	Anderson, Eric C.	715/720
*	B	US-6,122,411	09-2000	Shen et al.	382/299
*	C	US-6,577,311	06-2003	Crosby et al.	345/428
*	D	US-6,661,454	12-2003	Hwang et al.	348/231.1
*	E	US-7,130,394	10-2006	Koyama et al.	379/93.23
*	F	US-7,193,646	03-2007	Shioji, Masahiro	348/220.1
*	G	US-7,233,356	06-2007	Nagao, Seiji	348/333.02
*	H	US-7,308,158	12-2007	Herbert et al.	382/298
*	I	US-2003/0218682	11-2003	Lim et al.	348/333.11
*	J	US-2004/0016814	01-2004	Muramatsu, Takeharu	235/462.41
*	K	US-2004/0051784	03-2004	Ejima et al.	348/207.99
*	L	US-2004/0201692	10-2004	Parulski et al.	348/207.1
*	M	US-2004/0267793	12-2004	Sato, Tsuneo	707/100

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
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	X					

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